

**A survey on split manufacturing : attacks, defenses, and challenges**

**Perez, Tiago Diadami; Pagliarini, Samuel Nascimento** IEEE Access 2020 / p. 184013-184035

<https://doi.org/10.1109/ACCESS.2020.3029339> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

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**Pagliarini, Samuel Nascimento** 2021 IEEE 22nd Latin American Test Symposium (LATS), Punta del Este, Uruguay, 27-29 October

2021 2021 / 3 p. : ill <https://doi.org/10.1109/LATS53581.2021.9651741>